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Express Mail No. EV 447 216 249 US Sheet 1 of 1

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO. 11856.00	APPLN. NO. 09/628,116		
APPLICANT: Roman Sobolewski et al.			
FILING DATE	GROUP	_	
July 28, 2000	2878		

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
T.M.	4,894,542	01/1990	Schneider	250	336.2	

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

DOCUMEN	NT PUBLISHED				TRANSL	ATION
NUMBER	R DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
					 	
						
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

T.M.	*Gupta et al., D., "Single-Photon-Counting Hotspot Detector With Integrated RSFQ Readout Electronics", IEEE Transactions on Applied Superconductivity, Vol. 9, No. 2, pgs. 4487-4490 (June 1999).				
T.M.	Il'in K.S. et al., "Ultimate Quantum Efficiency of a Superconducting Hot-Electron Photodetector", Applied Physics Letters, Vol. 73, No. 26, pp. 3938-3940 (December 28, 1998).				
T.M.	Somani, S. et al., "New Photon Detector for Device Analysis: Super conducting Single-Photon Detector Based on a Hot Electron Effect", Journal of Vacuum Science & Technology B, Vol. 19, No. 6, pp. 2766-2769 (November/December 2001).				
T.M.	Gol'tsman G. et al., "Fabrication and Properties of an Ultrafast NbN Hot-Electron Single-Photon Detector", IEEE Transactions on Applied Superconductivity, Vol. 11, No. 1, pp. 574-577 (March, 2001).				
EXAMINER	7 in hom Date considered 6-28-04				

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

^{*}Previously cited to the Office on March 31, 2003.